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Fairchild Semiconductor FDZ5047N

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FDZ5047N

30V N-Channel Logic Level PowerTrench[®] BGA MOSFET

General Description

Combining Fairchild's 30V PowerTrench process with state of the art BGA packaging, the FDZ5047N minimizes both PCB space and $R_{DS(ON)}$. This BGA MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, high current handling capability, ultra-low profile packaging, low gate charge, and low $R_{DS(ON)}$.

These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable $R_{\text{DS}(\text{ON})}$ specifications resulting in DC/DC power supply designs with higher overall efficiency.

Applications

- DC/DC converters
- Solenoid drive

- Features
- 22 A, 30 V. $R_{DS(ON)} = 2.9 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$ $R_{DS(ON)} = 4.5 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$

FDZ5047N

January 2004

- Occupies only 27.5 mm² of PCB area: 1/5 of the area of a TO-220 package
- Ultra-thin package: less than 0.90 mm height when mounted to PCB
- · Outstanding thermal transfer characteristics
- Ultra-low gate charge x $R_{DS(ON)}$ product
- $\begin{array}{c|c} \hline 0 & 0 & 0 & 0 & 0 \\ \hline 0 & 8 & 8 & 8 & 0 \\ \hline 0 & 8 & 8 & 8 & 0 \\ \hline 0 & 8 & 8 & 8 & 0 \\ \hline 0 & 8 & 8 & 8 & 0 \\ \hline D & 8 & 8 & 8 & 0 \\ \hline D & 6 & 8 & 8 & 0 \\ \hline Bottom & Top \end{array}$

Symbol	Parameter			Ratings	Units
V _{DSS}	Drain-Source Voltage			30	V
V _{GSS}	Gate-Source Voltage			±20	
I _D	Drain Curre	nt – Continuous	(Note 1a)	22	A
		 Pulsed 		75	
PD	Total Power Dissipation $@$ T _A = 25°C			2.8	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-50 to +150	°C
0, 010	- p - i - i - i - j - i	na eterage eanetter remp	for a tailing o		0
Therma	l Charac	teristics			
Therma	l Charac	i		44	°C/W
Therma R _{0JA}	I Charac	teristics		44 2.7	
	I Charac Thermal Re Thermal Re	teristics sistance, Junction-to-Amb	ient (Note 1a) (Note 1)		
Therma R _{0JA} R _{0JB} R _{0JC}	I Charac Thermal Re Thermal Re Thermal Re	teristics sistance, Junction-to-Amb sistance, Junction-to-Ball	ient (Note 1a) (Note 1) e (Note 1)	2.7	
Therma R _{0JA} R _{0JB} R _{0JC} Packag	I Charac Thermal Re Thermal Re Thermal Re	teristics sistance, Junction-to-Amb sistance, Junction-to-Ball sistance, Junction-to-Case	ient (Note 1a) (Note 1) e (Note 1)	2.7	

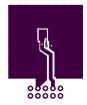
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FDZ5047N Rev D4 (W)



Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics			1		
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 V$, $I_D = 250 \mu A$	30	1		V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		24		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 V$, $V_{GS} = 0 V$			1	μA
I _{GSSF}	Gate–Body Forward Leakage	$V_{GS} = 20 V$, $V_{DS} = 0 V$			100	nA
I _{GSSR}	Gate–Body Reverse Leakage	$V_{GS} = -20 V$, $V_{DS} = 0 V$			-100	nA
On Char	acteristics (Note 2)	•				
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	1	1.3	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 µA, Referenced to 25°C		-5		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance			2.3 3.2 3.4	2.9 4.5 5.0	mΩ
g fs	Forward Transconductance	$V_{DS} = 10 \text{ V}, \qquad I_D = 22 \text{ A}$		100		S
Dvnamic	Characteristics	·		•		
C _{iss}	Input Capacitance	$V_{DS} = 15 V$, $V_{GS} = 0 V$,		4993		pF
Coss	Output Capacitance	f = 1.0 MHz		1144		pF
Crss	Reverse Transfer Capacitance		-	498		pF
Switchin	g Characteristics (Note 2)	•	•			
t _{d(on)}	Turn–On Delay Time	$V_{DD} = 15 V$, $I_{D} = 1 A$,		11	20	ns
tr	Turn–On Rise Time	V_{GS} = 10 V, R_{GEN} = 6 Ω		12	22	ns
t _{d(off)}	Turn–Off Delay Time			119	190	ns
t _f	Turn–Off Fall Time			55	88	ns
Qg	Total Gate Charge	$V_{DS} = 15 V$, $I_D = 22 A$,		52	73	nC
Q _{gs}	Gate–Source Charge	$V_{GS} = 5 V$		11		nC
Q _{gd}	Gate–Drain Charge	1		17		nC
Drain-Se	ource Diode Characteristics	and Maximum Ratings				
l _s	Maximum Continuous Drain–Source				2.3	А
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$, $I_S = 2.3 A$ (Note 2)		0.7	1.2	V
trr	Diode Reverse Recovery Time	I _F = 22A,		42		nS
Q _{rr}	Diode Reverse Recovery Charge	d _{iF} /d _t = 100 A/μs		59		nC

1. $R_{a,JA}$ is determined with the device mounted on a 1 in² 2 oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. The thermal resistance from the junction to the circuit board side of the solder ball, $R_{a,JB}$ is defined for reference. For $R_{a,JC}$, the thermal reference point for the case is defined as the top surface of the copper chip carrier. $R_{a,JC}$ and $R_{a,JB}$ are guaranteed by design while $R_{a,JA}$ is determined by the user's board design.



Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%

a) 44°C/W when mounted on a 1in² pad of 2 oz copper

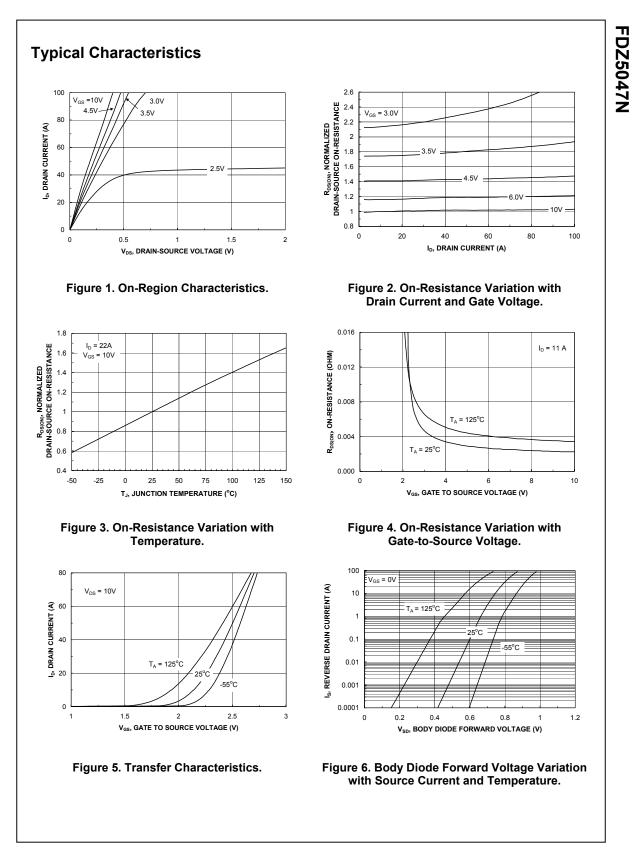


b) 95°C/W when mounted on a minimum pad of 2 oz copper

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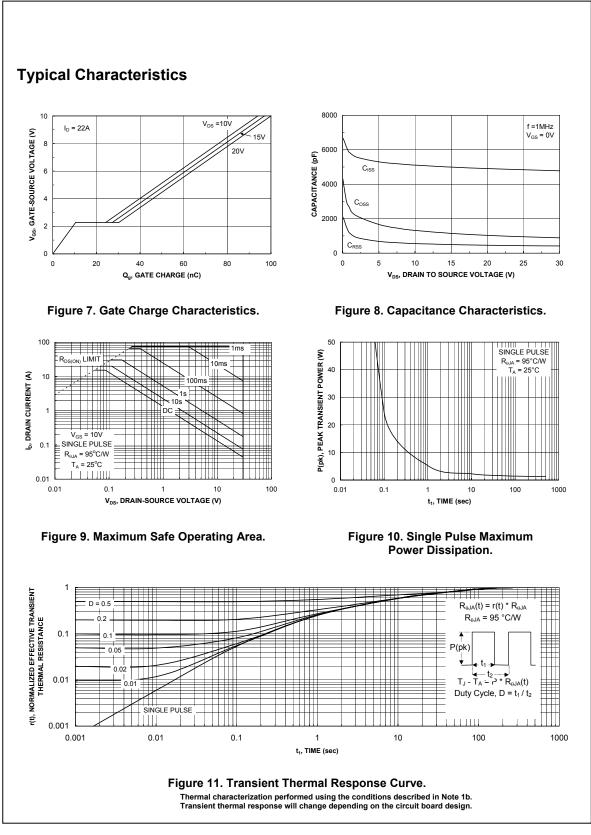
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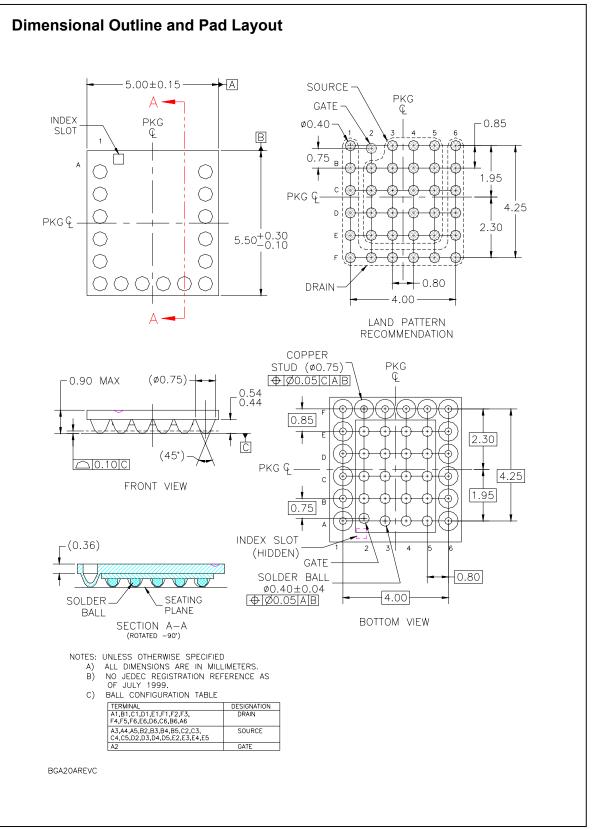




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